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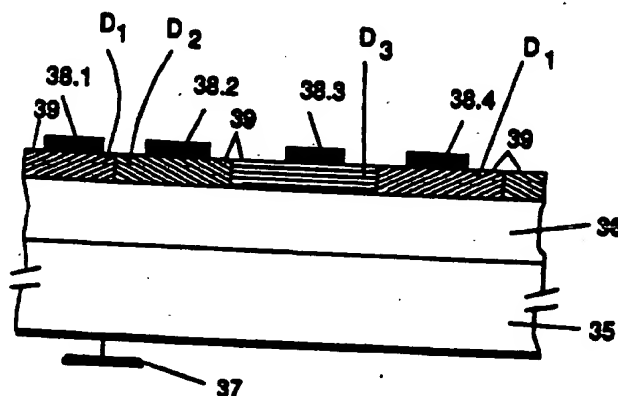
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(54) Title: MONOLITHIC ARRAY OF LIGHT EMITTING DIODES FOR THE GENERATION OF LIGHT AT MULTIPLE
WAVELENGTHS AND ITS USE FOR MULTICOLOR DISPLAY APPLICATIONS

(57) Abstract

Disclosed are monolithic multicolor arrays of light emitting diodes and their use for multicolor display applications. A multicolor LED array comprises a conductive substrate (35), a conductive semiconductor layer (36), a compensated semiconductor layer on top of the active layer (36), and contacts (37; 38.x, x=1, 2, ...) for biasing individual LEDs. The compensated semiconductor layer serves as active layer of the LEDs for the generation of light. The multicolor capability of the active layer is achieved by using impurity related electronic transitions as radiative recombination processes, the energy of these transitions being dependent on the doping conditions, and by introducing a lateral variation of the doping conditions of the active layer. This lateral variation (different doping conditions are denoted by different symbols D_i , $i=1, 2, \dots$) is tailored such that a lateral variation of the color of the light generated in the active layer occurs due to the injection of carriers into the active layer, thus leading to LEDs with different emission wavelengths. The use of wide-bandgap semiconductors such as $(Ga_{1-x}Al_x)_{1-y}In_yN$ for the active layer allows for fabricating monolithic multicolor LED arrays capable of generating different emission lines, all together spanning the entire spectrum between near infrared and ultraviolet.

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DESCRIPTION

Monolithic array of light emitting diodes for the generation of light at multiple wavelengths and its use for multicolor display applications

TECHNICAL FIELD

The present invention relates to monolithic arrays of light emitting diodes for the generation of light at multiple wavelengths, and multicolor displays based on such arrays.

BACKGROUND OF THE INVENTION

In our technical world displays have an important function as human interfaces for making abstract information available through visualization. In the past, many applications for displays were identified and realized, each with its own specific requirements. Therefore, different display technologies have been developed, each having their own strengths and weaknesses with respect to the requirements of particular display applications, thus making a particular display technology best suited for a particular class of applications.

The most important display applications being pursued are based on cathode ray tubes (CRT), liquid crystal displays (LCD), or vacuum fluorescent, plasma, light emitting diode (LED), electroluminescent, and electromechanic displays. Among the most decisive criteria dictating an appropriate display technology are cost of fabrication, power efficiency, reliability, weight, size of screen, depth, brightness, gray-scale capabilities, dynamic range, resolution (i. e. the minimum size of an addressable picture element on the display), contrast, dependence of the contrast on the viewing

1 angle, switching speed of a particular pixel (pixel element), sunlight
readability, color range, chrominance and chrominance contrast. CRTs
have a dominant position on the display market due to their low price and
their multicolor, high resolution and gray-scale capabilities. However, they
5 have disadvantages if low weight, low power, small depth and sunlight
readability is desired, for example in applications for battery driven portable
computers.

10 The other mentioned display technologies come into play in areas where
CRTs show weaknesses, especially if the weight, the depth and/or the power
consumption of CRTs are simply not acceptable. For example, in
applications for wrist watches or portable computers - an important domain
of flat panel displays - or, generally, in applications which require large
and/or flat displays, alternate technologies are preferred.

15 Due to their advantages - low weight, low power consumption, low depth -
LCDs became the dominant flat panel display technology. The LC-material
is cheap and the fabrication processes are scalable although at
considerable cost, so that displays of arbitrary size can be made. However,
20 many applications such as high resolution graphics or full motion video
require high resolution, often in combination with high pixel switching
speed. In these cases, LCD technology has drawbacks. In LCDs, high
resolution is achieved with x-y matrix addressing techniques, thus reducing
the number of address lines. However, x-y matrix addressing, in
25 combination with the fundamental physical properties of LC materials, lead
to high resolution only at the expense of a poor contrast between adjacent
pixels, a small maximum viewing angle and other effects further
deteriorating image quality, for example cross talk between pixels. These
drawbacks can be partly overcome with so called 'active' x-y matrix
30 addressing (see "A gray-scale addressing technique for
thin-film-transistor/liquid crystal displays" by P. M. Alt et al., IBM Journal of
Research and Development Vol. 36, No. 1, pp. 11-22, 1992). However, active
matrix addressing requires a network of transistors of the same size as the

1 display its If, each transistor controlling the charge stored in one capacitor,
each capacitor influencing the orientation of the LC molecules between its
electrodes and thus defining one pixel of the entire display. Today, the
active matrix addressing makes possible brilliant full color displays capable
5 of graphics with reasonable resolution or full motion video. However, large
flat panel LCDs with active matrix addressing are expensive due to the costs
of the fabrication of the transistor matrix array. Despite of the improvements
due to the active matrix addressing, undesirable drawbacks remain such as
the still limited viewing angle and the resolution being limited today to
10 minimum pixel sizes of $100\mu\text{m} \times 100\mu\text{m}$. Furthermore, the pixel size
determines the maximum magnification factors of projection displays, i. e.
displays which generate a secondary virtual or real image from a primary
display element by means of optical imaging and thus allow for the
generation of magnified images, provided the resolution of the original
15 image prior to projection was sufficient.

Large high resolution LCDs with sizes more than 30 inches diagonal are
difficult and expensive to fabricate. Therefore, large flat displays, as desired
for high definition TV (HDTV) or public information boards, are the domain
20 of vacuum fluorescent, electroluminescent or plasma displays despite their
poorer power efficiencies. In particular, large full-color flat-panel plasma
displays have excellent potential to replace cathode ray tubes in HDTV in
the near future.

25 Light emitting diode (LED) displays are flat and lightweight, have sunlight
viewability, and have - in comparison with LCDs - an excellent viewing
angle and a high response speed of the order of 10-20 ns compared with
10-100 ms for LCDs. In addition, LED displays can have a smaller pixel size
than LCD displays. LED displays have a pixel size dictated by the
30 dimensions of a single LED, which can be quite small since it is defined by
semiconductor lithography ($\approx 1\mu\text{m} \times 1\mu\text{m}$ or less). The smallest pixel size of
LCD displays is (about $100\mu\text{m} \times 100\mu\text{m}$) dictated by the physical properties
(such as size of molecules, viscosity, etc.) of liquid crystals. The rapid

1 modulation speed of LED displays makes it possible to use simple
2 modulation techniques, e. g. on/off switching, for enhancing gray-scale
3 capabilities. For example, for n gray-levels the LED switches on 0 - n times
4 inside of a single cycle.

5
6 LED displays entered the market place as a replacement for vacuum tube
7 displays and were used as small indicators on instruments and small
8 alphanumeric devices in hand-held computers. However, they lost market
9 share to LCD technology in certain areas where the cost of their substrates
10 and fabrication lead to unfavorable prices, or where the power consumption
11 of LEDs was not competitive. On the other hand, these arguments in favor
12 for LCD technology become less important for several reasons. First,
13 progress in materials science and technology lead to advances in LED
14 devices in terms of their power efficiency and further progress can be
15 expected. Furthermore, the power advantage of LCDs is significant mainly in
16 applications in which the LCD is used in a nonemissive mode, i.e. the LCD
17 is illuminated by ambient light and acts only as reflective or transmissive
18 spatial filter. In this case, power is only used for addressing and switching
19 individual pixels. These are low power processes compared with driving
20 emissive devices such as LEDs. However, there are many applications
21 where LCDs cannot be used in a nonemissive mode, but must be
22 illuminated with lamps, for example in high-brightness displays for laptop
23 computers. In these cases, the power advantage of LCDs becomes
24 questionable. The price argument in favor for LCDs becomes less important,
25 when active matrix x-y addressing must be used. Then, the major part of
26 costs must be attributed to the fabrication of the transistor matrix for
27 addressing.

28 Therefore, areas of application for LED displays arise where advantageous
29 features such as maximum viewing angle, fast response speed, and minimal
30 pixel size are desired. However, the prospects of LED displays depend on
the solutions of numerous problems, for example the color capabilities, the

1 Integrati n f different addressabl LED-based light sources of different
c lor n a mon lithic chip, and the maximum size f such a monolithic chip.

Whereas 10 inches diagonal LCDs are common even with active matrix
5 addressing and systems twice as large are in an experimental stage, the
size of monolithic LED devices is typically between 2 and 25 mm and
limited by the available size of the substrates on which the LEDs are
fabricated, with the LEDs being normally realized in epitaxial semiconductor
10 layers grown on said substrates. Larger LED based displays have been
developed, but not in a monolithic version. They have been assembled
using single diodes or monolithic modules having a small number of display
points. A display with a resolution of 64 lines per inch, 4 inches by 4 inches
in size, with 49,000 light emitting junctions composed of 1/4 inch times 1/4
15 inch GaP LED arrays, each array containing 16x16 light emitting junctions, is
known from "Multi-Mode Matrix Flat Panel LED Varactor Concept
Demonstrator Display" by K. T. Burnette , Proceedings of the Society for
Information Display, Vol. 21/2, pp. 113-126, 1980. Other examples for hybrid
LED displays are given in "A High-Brightness GaP Green LED Flat-Panel
20 Device for Character and TV Display" by Tatsuhiko Niina et al., IEEE
Transactions on Electron Devices, Vol. ED-26, No. 8, pp. 1182-1186, 1979.

Presently, full (in particular 3) color gray-scale capable matrix-addressable
LCDs with 10 inches diagonal and a pixel size of $100\mu\text{m} \times 100\mu\text{m}$ are state
of the art. Color capability is achieved by providing a flat display illuminated
25 by white light through a 3-color filter array such that each pixel, the smallest
picture element of the display, is subdivided into 3 adjacent independent
subpixels, each subpixel representing one of three elementary colors - blue,
green and red - which can be mixed with variable intensities such that any
single pixel gives the impression of radiating any predefined color of the
30 white light spectrum at any gray-level between zero intensity (defining
"black" color) and a predefined maximum value.

1 S far, multicolor LED flat panel displays have been assembled from
discret LEDs (see for example "A multicolor GaP LED flat panel display
device" by T. Nina et al., 1981 SID Int. Symp. Digest Tech. Papers 12, pp.
140-141, 1981). In order to simplify manufacturing of such a device by
5 taking advantage of modern semiconductor integration and processing
technology, monolithic multicolor LED based devices providing a multitud
of LEDs would be desired, whereby either individual LEDs generate discrete
colors tunable over a certain range, or at least two different groups of LEDs
exist, each being characterized by a common wavelength of its LEDs, the
10 common wavelengths of different groups being distinguishable. The
meaning of the word 'distinguishable' in this context depends on the
application, namely on the observer. If the observer is a person, the person
should be able to distinguish different colors. If the display is interpreted by
color-sensitive instruments, the instrument's color sensitivity is relevant.

15 The above-mentioned list of characteristic features of monolithic devices
with integrated multicolor LEDs is not complete, if the display has to show
arbitrary image data including chromatic contrasts. Then, monolithic devices
providing a two-dimensional array of equivalent multicolor pixels, the pixels
20 being distributed on a flat substrate, would be desired, whereby each pixel
is either represented by at least one LED generating a color tunable within a
certain range under electronic control and/or is represented by a group of
spatially separated LEDs, each being capable of generating one of two or
even more distinguishable wavelengths. For a natural representation of any
25 arbitrary visible color, the generation of three wavelengths at the position of
each pixel is desired, for example one wavelength belonging to the blue,
another to the green and the third to the red part of the visible spectrum.

30 However, monolithic multicolor LED arrays providing a 1- or 2-dimensional
distribution of individually addressable light sources on a substrate and
providing 2 or more distinguishable colors are not known in the art. A
special unsolved problem is the integration of LEDs capable of covering the
entire spectrum of visible light.

1 In the following, the color capabilities of visible LEDs with special emphasis
on the integration of different colors on the same substrate are briefly
summarized, as it is known in the art. Semiconductor technologies are
5 known to fabricate single monochrome LEDs for the entire spectrum of
visible light. An overview about such technologies is given in textbooks
such as "Flat-Panel Displays and CRTs", edited by L. E. Tannas, Van
Nostrand Reinhold Company, Chapter 9, pp. 289-331, 1985. In the majority of
10 applications, either direct electronic band-to-band transitions or
impurity-induced indirect band-to-band transitions in the material forming
the active region of the LED are used for light generation. In these cases,
the energy gap of the material chosen for the active region of the LED, i. e.
the zone where the electronic transitions responsible for the generation of
15 light within the LED take place, determines the color of a particular LED. A
further known concept for tailoring the energy of the dominant optical
transition of a particular material and thus the wavelength of the generated
light is the incorporation of impurities leading to the introduction of deep
traps within the energy gap. In this case, the dominant optical transition
20 may take place between a band-state of the host material and the energy
level of the deep trap. Therefore, the proper choice of an impurity may lead
to optical radiation with photon energies below the energy gap of the host
semiconductor. In this case, the impurities, the host-semiconductor and the
exact alloy composition chosen for the active layer offer three degrees of
25 freedom for the design of a LED with a particular wavelength since the
bandgap induced shift in the impurity levels in alloys would change the
emission color.

30 Today, exploiting these two concepts for tailoring the emission wavelength
of an LED and using III-V or II-VI compound semiconductors or their alloys
for the active region of the LED, it is possible to cover the optical spectrum
between near infrared and blue with discrete emission lines. However, due
to constraints on the growth of high quality semiconductor layers, the
general problem arises whether it is feasible to combine materials, doping

1 conditions and device concepts for LEDs such that different wavelengths can
be generated from a monolithic LED array.

5 In the majority of LED technologies, the active region is placed between
appropriate semiconductor cladding layers, one being doped p-type and the
other being doped n-type, and the optical transitions are induced by
injecting electrons and holes into the active layer by applying an
appropriate bias between the cladding layers. An important and sometimes
10 restrictive premise of this approach is the existence of proper cladding
materials which can be doped p- as well as n-type and can serve as
substrates for the fabrication of high quality active regions. Examples of
common materials for active regions in p-n-type LEDs and the spectral
regions they are best suited for are summarized in the following, whereby
15 spectral data are in general room temperature values. Materials mostly
used are III-V semiconductors such as GaAs, GaAlAs, GaP, GaAsP, GaInP,
AlGaInP, GaN, AlGaIn, InAlGaIn, and II-VI compounds such as ZnSe/CdZnSe,
CdZnSeS or MgCdZnSeS, and the IV-IV compound SiC.

20 Direct band-to-band transitions in GaAs are used for the generation of
Infrared light at around 870 nm. Exploiting direct band-to-band transitions
in $\text{Ga}_x\text{Al}_{1-x}\text{As}$, the infrared/red spectral range between about 867nm and
about 652nm can be covered by choosing an appropriate molar fraction x.
The material system $\text{GaAs}_{1-x}\text{P}_x$ is suitable for the spectral range
867nm - 610nm (i.e. infrared - red) when exploiting direct transitions
25 ($x < 0.49$), and appropriate for 610nm - 548nm (i.e. red - green) when taking
advantage of indirect band-to-band transitions which can be enabled by
impurity induced processes by doping with isoelectronic impurities such as
nitrogen.

30 For blue light generating LEDs, wide bandgap semiconductors such as SiC,
GaN, AlGaIn, InAlGaIn, ZnSe/CdZnSe or CdZnSeS are candidates. Until
recently, the majority of such wide bandgap materials could not be grown p-
as well as n-doped. Therefore, LEDs based on the conventional concept of

1 exploring p-n-junctions for carrier injection into the active region were not
feasible. To circumvent this inconvenience, MIS-type diodes (i.e.
metal-insulator-semiconductor diodes) have been successfully applied. In
MIS-type LEDs, the active layer is made insulating and sandwiched between
5 a conductive semiconductor layer and a metal contact. By applying an
appropriate bias V between metal and conductive semiconductor layer,
electrons are injected into the active layer, whereby the electron emitter is
either the negatively biased metal layer or, if the semiconductor layer is
n-doped, the negatively biased semiconductor layer. In the active layer, the
10 injected electrons radiatively recombine with holes, which are refreshed by
the counter electrode, the counter electrode being either the positively
biased metal layer, if the electron emitter is an n-doped semiconductor
layer, or an n- or p-doped semiconductor layer. Such structures show
typical diode-like nonlinear current-voltage characteristics including a
15 threshold voltage and an exponential increase of the injected current as a
function of the applied bias V . The highest power efficiencies are usually
achieved by emitting electrons from a n-type semiconductor layer towards
the metal electrode, which serves as anode of the device. The overall
performance of a MIS-LED, in particular the relationship between the
20 injected current I and the applied bias V and the relationship between the
intensity of the generated light and the injected current I , depend on many
physical processes related to the carrier injection (e. g. tunneling, thermal
excitation over barriers) and the carrier transport in the active layer (e. g.
field ionization of deep impurities, impact ionization of deep impurities,
25 hopping transport of holes, space charge current limitations, etc.). A more
detailed discussion of these physical processes is not relevant for the
understanding of this application, since an optimization of the performance
of MIS-LEDs is not an object of this invention. In this context, it is sufficient
to mention the relevance of the thickness of the insulating layer for the
30 power efficiency of MIS-LEDs. For the thickness of the insulating layer, a
trade-off exists. If it becomes too thin, an increasing part of the injected
electrons passes through the insulating layer directly into the anode of the
device without radiative recombination, thus lowering the power efficiency. If

1 the insulating layer is too thick, the series resistance and the threshold
voltage increase, again lowering the power efficiency. Typical values for an
optimized thickness of the insulating layer, taken for a GaN-based MIS-LED,
are in the range 20nm - 1 μ m (see "GaN electroluminescent devices:
5 preparation and studies" by G. Jacob et al., Journal of Luminescence Vol.
17, pp. 263-282, 1978).

Blue light emitting MIS diodes have been realized in the GaN system.
Examples of these have been published in:

10

- "Violet luminescence of Mg-doped GaN" by H. P. Maruska et al., Applied
Physics Letters, Vol. 22, No. 6, pp. 303-305, 1973,
- "Blue-Green Numeric Display Using Electroluminescent GaN" by J. I.
Pankove, RCA Review, Vol. 34, pp. 336-343, 1973,
- 15 - "Electric properties of GaN: Zn MIS-type light emitting diode" by
M. R. H. Khan et al., Physica B 185, pp. 480-484, 1993,
- "GaN electroluminescent devices: preparation and studies" by G. Jacob et
al., Journal of Luminescence, Vol. 17, pp. 263-282, 1978,
- EP-0-579 897 A1: "Light-emitting device of gallium nitride compound
20 semiconductor".

In these studies, a common substrate for GaN is used, namely sapphire. On
the sapphire substrate, a thick (several 100 μ m) layer of n-type GaN was
grown, often unintentionally doped GaN. On top of the n-GaN layer, the
25 active layer of insulating GaN was grown. The insulating nature was realized
by the incorporation of acceptors such as Zn, Cd or Mg during growth which
compensate intrinsic donors and thus reduce the conductivity. Metals such
as In, Ni, Ag, or Al served as metal contacts to the insulating active layer.
As the sapphire substrate is insulating, special attempts are necessary to
30 apply a bias to the MIS-diode. For making a contact to the n-GaN layer,
either side contacts at the edges of the substrate are formed, or the n-GaN
layer is made accessible from above by etching contact holes through the
insulating GaN active layer.

1
It has also been recognized in the above-mentioned articles that the
compensation of the insulating GaN layer by impurities such as Zn, Cd, or
Mg can lead to different coexistent impurity levels within the energy gap of
5 the host semiconductor whereby the density of the impurity states depends
on the doping conditions, i. e. on the type of impurity, its concentration
and/or the growth conditions. It is further known that the dominant
electronic transitions which contribute to the electroluminescence of the
compensated GaN layer take place between the lowest conduction band and
10 an impurity state within the energy gap. Therefore, depending on the energy
of the impurity states involved in the electroluminescent processes, light is
generated with photon energies of the bandgap reduced by the binding
energy of the impurity state. Therefore, by appropriate tailoring of the
distribution of impurity states, the peak of the GaN electroluminescence
15 spectrum, which is in the ultraviolet if band-to-band transitions are
dominant, is red-shifted due to the introduction of impurities. Based on this
concept, GaN MIS-LEDs have been fabricated with peak wavelengths in the
blue, green, yellow, orange and red part of the spectrum, together spanning
the entire visible spectrum. The quantum efficiency as well as the threshold
20 voltage of such devices are related to the color of their radiation. Quantum
efficiencies of about 0.5% and 0.1% have been demonstrated for the
green-yellow and for the blue part of the visible spectrum, respectively.
Typical threshold voltages are 4V for the blue, 5V for the green, and 10V for
the yellow.

25
Recently, due to progress in the development of techniques for p-doping of
GaN and related compounds such as InGaN and AlGaN, the first p-n-type
blue GaN based LEDs have been demonstrated. One example representing
the state of the art is given in "Candela-class high-brightness InGaN/AlGaN
30 double-heterostructure blue-light-emitting diodes" by S. Nakamura et al.,
Applied Physics Letters, Vol. 64, No. 13, pp. 1687-1689, 1994. The vertical
layer structure of the LED disclosed in this article consists of a stack of
GaN/AlGaN/InGaN layers grown on sapphire. The activ layer consists of

1 Zn doped InGaN sandwiched between p- and n-doped AlGaIn layers, the
sandwich forming a double-heterostructure. The Zn doping leads to optical
transitions whose energy is related to the energy of Zn-related impurity
states in a similar way as it is known for GaN (see above). Since the
5 sapphire substrate of this device is not conductive, contact holes are etched
through the active layer in order to get access to the n-GaN layer
underneath.

Recent progress in developing doping techniques for II-VI semiconductors
10 such as ZnSe, CdZnSe or CdSSe allows these materials to be exploited for
the fabrication of p-n-junction based blue-light-emitting LEDs and even laser
diodes. An impression about the state of the art of the growth of II-VI
wide-bandgap materials can be taken from the article "Blue-green diode
lasers" by G. F. Neumark et al., Physics Today 6, pp. 26-32, 1994.

15 In summary, using different semiconductor materials, their alloys and the
incorporation of impurities, different materials for active layers of LEDs are
available to fabricate single LEDs emitting light at wavelengths spanning the
entire visible spectrum. However, concepts to integrate different LED-based
20 light sources with multicolor capability on a single substrate are barely
developed.

Variable hue GaN MIS-LEDs which change their color as a function of bias
are known from the article "GaN electroluminescent devices: preparation
25 and studies" by G. Jacob et al., Journal of Luminescence, Vol. 17, pp.
263-282, 1978. The wavelength tuning of such LEDs is based on the
coexistence of different impurity levels in the energy gap of the host
semiconductor and the bias dependence of their occupation with electrons.
At low bias, the transitions with the lowest energy occur. However, with
30 increasing bias, the emission due to this transition saturates, whereas a
transition with a higher energy appears with increasing intensity and begins
to dominate the electroluminescence spectrum at even further increased
bias. The article cited above gives the example of a GaN MIS-LED which

1 mixes yellow and blue light with an increasing share of blue light as a function of increasing bias, both colors being generated in the same active region.

5 A variable hue LED which resembles the preceding example was previously disclosed in the article "Variable Hue GaP Diodes" by W. Rosenzweig et al., Solid-State Electronics, Vol. 14, pp. 655-660, 1970. In this case, GaP is the host material and nitrogen and ZnO are used as dopants which generate different impurity states giving rise to electroluminescence at two
10 wavelengths, red and green, the intensity of both colors being interrelated depending on the bias.

Another concept of integrating different LED-based light sources with different colors on a single substrate is the vertical integration of different
15 active regions, each contributing to one particular of different emission lines. One example in accordance with this approach is given in the article "A Multi-Color GaP LED Flat Panel Display Device" by T. Niina, 1981 DID Int. Symp. Digest Technical Papers 12, pp. 140-141, 1981. The device disclosed consists of a stack of GaP layers, alternatively doped n-, p-, p-, and n-type,
20 thus forming two p-n-junctions on top of each other which are electrically isolated from each other. The active region in one p-n-junction is doped such that impurity induced indirect band-to-band transitions result in the radiation of green light (see above). The other p-n-junction contains ZnO impurities enabling the generation of red light with photon energies below
25 the energy gap of GaP due to transitions to impurity levels within the bandgap. In order to bias both p-n-junctions independently, three electrodes are necessary whereby complicated processing steps are required for their fabrication, namely the etching of isolation trenches for the electrical isolation of the electrodes and the local overcompensation of the top n-GaP
30 layer with acceptors for enabling electrical contact to the p-GaP layers. The possibility of independently biasing each p-n-junction allows for the generation of any intermediate color between red and green, whereby for an observer, the light seems to come from a single light source. According to

1 the above-mentioned reference, single elements of such 2-color LEDs have
been made and used as picture elements of large flat panel displays for TV
applications.

5 Up to now, these concepts have not been extended to provide a multitude of
multicolor LED-based light sources on a single substrate. In particular, the
question of how to provide a multitude of LED-based light sources with
predefined colors between blue and red, with predefined shape, and
predefined position on a single substrate has not been tackled.

10

SUMMARY OF THE INVENTION

15 It is an object of this invention to provide a monolithic array of light emitting
diodes for the generation of light at multiple wavelengths.

It is a further object of this invention to provide a monolithic array of light
emitting diodes for the generation of light at multiple wavelengths, together
spanning the entire visible spectrum.

20

It is a further object of this invention to propose a monolithic array of light
emitting diodes for the generation of light at multiple wavelengths which are
simple and cheap to manufacture, and to propose appropriate materials for
the LEDs and the substrates.

25

It is a further object of this invention to provide applications of monolithic
multicolor LED arrays for displays with special emphasis on high resolution
full color displays with gray-scale and video capability, whereby the term
full color denotes the capability of representing any color of the visible
30 spectrum. The LEDs may represent light sources of any shape or size, thus
defining arbitrary picture elements of a display.

- 1 The invention as claimed is intended to meet these requirements. It
provides an array of light emitting diodes (LEDs) for the generation of light
at multiple wavelengths, the LEDs being realized in a layered structure of
semiconductor films grown on one substrate, said array comprising contact
5 areas for applying a bias to said LEDs, at least two particular LEDs of said
LEDs having different electroluminescence spectra obtained in that
- only the first of said particular LEDs has an electroluminescence
spectrum being determined by impurity states in the material forming
10 its active region, said impurity states leading to optical transitions with
energies below the bandgap energy of said active region, or
 - both of said particular LEDs have at least one impurity state in the
material forming the respective active region, said impurity states
15 being different for both of said LEDs due to different local doping
conditions, and each of said impurity states leads to optical transitions
with energies below the bandgap energy of said active region, said
optical transitions contributing to said electroluminescence spectra of
said particular LEDs, or
 - said electroluminescence spectra of both of said particular LEDs
20 comprise at least two emission lines with different emission
wavelengths, both of said emission lines being attributed to optical
transitions which are related to impurity states in the material forming
the active region of said LEDs and have a photon energy below the
bandgap energy of said active region; said two emission lines having
25 the same photon energy but different relative intensities for said
particular LEDs.
- 30 The basic idea behind this invention is the choice of a semiconductor
material which can be modified by doping such that its electroluminescence
spectrum contains one or more emission lines which are due to electronic
transitions from excited electronic states of the semiconductor material to

1 one or more doping-induced impurity states within the energy gap, whereby
it is assumed that the wavelength of the impurity-induced emission lines are
influenced by the doping conditions, for example the kind of dopants, the
mixture of different dopants, the doping concentration, or the method of the
5 doping procedure. The bandgap of the active-layer material determines the
shortest wavelength to be generated by electroluminescence. Therefore, a
wide-bandgap semiconductor with a bandgap of ≈ 3 eV is used for the
active region of the LEDs if the emission wavelengths span the entire visible
spectrum between Infrared and ultraviolet. Using such a material for the
10 active region of LEDs, there are different approaches possible to design
multicolor LED arrays in accordance with this invention.

One approach is based on an active layer with a lateral variation of the
doping conditions. Therefore, LEDs fabricated at different positions on the
15 substrate have different emission wavelengths. For the fabrication of
displays with an arbitrary distribution of picture elements of arbitrary shape
and arbitrary color, doping methods are exploited which allow for the local
incorporation of dopants after the growth of the active layer on a substrate
in combination with mask steps for the control of the lateral doping profile.
20 If the LEDs have only one emission wavelength, the emission wavelength of
a particular LED remains stable upon changing the bias applied to it
(provided that secondary effects such as temperature effects are neglected).
Different gray-scales are realized by changing the bias, and/or rapidly
modulating the LEDs with variable speed and/or amplitude.

25 The second approach is based on an active layer which is doped such that
two or more emission lines appear in electroluminescence. In this case, as
stated in the Introductory portion of this application, such an active layer
leads to variable hue LEDs which change color with bias, whereby the color
30 is actually a mixture of different elementary colors. Thus, a lateral variation
of bias with position on the substrate leads to a lateral variation of the color
generated in the active layer. This statement holds, even if the doping
conditions are homogeneous in the entire active layer. According to this

1 approach, a monolithic multicolor LED array in accordance with this
invention is realized by growing an appropriate layered structure of
semiconductors on an appropriate substrate whereby the layer serving as
the active layer of the LEDs is doped in agreement with the
5 above-mentioned criteria, and by subsequently fabricating a multitude of
LEDs on said layered structure, whereby the LEDs can be independently
biased.

On the basis of the multicolor LED arrays in accordance with this invention,
10 novel multicolor displays can be made by adding features such as means
for addressing individual LEDs and applying an appropriate bias to them,
interfaces for handling data to be displayed, timing systems for handling
time-dependent image data and/or gray-scale processors for handling gray
levels.

15

DESCRIPTION OF THE DRAWINGS

The invention is described in detail below with reference to the following
schematic drawings:

20

FIG. 1A shows an example of a layered structure of semiconductors on
top of a planar substrate for the fabrication of multicolor
MIS-type LED arrays.

25 **FIG. 1B** shows an example of a layered structure of semiconductors on
top of a planar substrate for the fabrication of multicolor
p-n-type LED arrays.

30 **FIG. 2** depicts an example for a multitude of pixels corresponding to
masks for the definition of lateral doping profiles and contact
areas of the inventive multicolor LED arrays.

- 1 **FIG. 3A** shows an example of a vertical profile of a MIS-type LED on a
nonconductive substrate.
- 5 **FIG. 3B** shows an example of a vertical profile of a MIS-type LED on a
conductive substrate.
- 10 **FIG. 4A** illustrates an example of a vertical profile of a p-n-type LED on
a nonconductive substrate.
- 15 **FIG. 4B** illustrates an example of a vertical profile of a p-n-type LED on
a conductive substrate.
- 20 **FIG. 5** depicts a portion of a high-density 2-dimensional x-y
addressable LED array on a conductive substrate serving as
common electrode. The electron emitting and electron
collecting layers are vertically arranged.
- 25 **FIG. 6** depicts a portion of an array of multicolor MIS-LEDs with a
lateral arrangement of the electron emitter and the electron
collector, the array being suitable for x-y addressing.
- 30 **FIG. 7** depicts a portion of a further embodiment of a multicolor
MIS-LED array with a lateral arrangement of the electron
emitter and the electron collector, the array being suitable for
x-y addressing.

GENERAL DESCRIPTION

In order to illustrate the inventive idea of this application, embodiments of multicolor LED arrays based on the material system $(\text{Al}_x\text{Ga}_{1-x})_y\text{In}_{1-y}\text{N}$ ($0 \leq x, y \leq 1$) are shown. The reason for this particular choice of a material system is twofold. First, for some members of this family of materials, doping induced multicolor electroluminescence has been demonstrated, as mentioned in the introductory portion. Second, this family of materials includes wide-bandgap semiconductors and is, therefore, a candidate of materials for full color displays covering the entire optical spectrum between near-infrared and near-ultraviolet.

On the other hand, doping-induced multicolor electroluminescence is not limited to $(\text{Al}_x\text{Ga}_{1-x})_y\text{In}_{1-y}\text{N}$ and can be considered as a general concept for semiconductors. For example, GaP doped with N leads to green electroluminescence and GaP doped with ZnO leads to red electroluminescence (see introductory part). Thus, the particular choice of the material system $(\text{Al}_x\text{Ga}_{1-x})_y\text{In}_{1-y}\text{N}$ does not mean any loss of generality concerning multicolor capability of semiconductor materials. However, it has the advantage of offering multicolor capabilities with an extreme spectral width compared with materials having a narrower energy gap. Other wide-bandgap semiconductor such as II-VI compounds serve for the same purpose.

The implementation of the inventive idea of this application leads to two different geometrical arrangements, the first being characterized by a vertical injection of carriers into the active region, whereas the second is based on a lateral injection (with respect to the substrate). First, the vertical arrangement is discussed.

Figures 1A and 1B show layered semiconductor structures based on $(\text{Al}_x\text{Ga}_{1-x})_y\text{In}_{1-y}\text{N}$. These layered structures are considered as starting points for the fabrication of preferred embodiments of this invention. They

1 are kept as simple as possible, i.e. only one layer serves as active layer for
the entire multicolor LED array. The layered structures shown in Fig. 1 are
used in the following for a demonstration of the inventive idea of this
application for two major LED technologies, namely MIS- and p-n-type
5 devices.

Initially, we discuss only devices based on crystalline materials. However,
the basic concepts being summarized in the following can be extended to
other states of solid matter, e.g. to polycrystalline or amorphous material.
10

Figure 1A shows an example of a layered structure of semiconductors on
top of a planar substrate for the fabrication of multicolor MIS-type LED
arrays. Several substrates are suitable for devices based on crystalline
($\text{Al}_x\text{Ga}_{1-x}$) In_yN , for example sapphire, SiC, ZnO or AlGaInN. Sapphire,
15 which is insulating, is the substrate material traditionally used. The
application of SiC, ZnO and AlGaInN as suitable substrates is also known
but not widespread. Below, it is shown that it is the good conductivity of SiC
and AlGaInN of which advantage can be taken, because due to this
property, means for applying a bias to a particular LED in a LED array can
20 be simplified, such simplification being one of the objects of this invention.
Both substrates, sapphire and SiC, are transparent for visible light. With
such substrates, the LEDs to be discussed in the following can be designed
such that the light generated by a particular LED is preferably emitted
through the substrate into the halfspace below the substrate (whereby the
25 term 'below' corresponds to the backside of substrate, i.e. the side not
being used for the deposition of the layers of semiconductors). In this case,
an antireflection coating optimized for the emission wavelengths is
deposited on the backside of the substrate in order to optimize the external
power efficiency of the LEDs and to avoid multiple reflections of the light
30 coming from a particular LED. Multiple reflections are not desired since they
lead to a multiple appearance of a single light source and thus to optical
crosstalk of adjacent LEDs, i.e. light which, for an observer, seems to come
from a particular LED might appear due to reflections of another LED in the

neighb hood. Such crosstalk is unfavorable in particular in high-resolution display applications which require small pixel sizes and thus a high density of LEDs. Of course, LED arrays based on the structures in Fig. 1 can be designed such that the electroluminescent light directed towards the halfspace above the substrate is used. In this case, too, multiple reflections at the backside of the substrate and the topside of the structure must be suppressed for the avoidance of optical crosstalk.

High-quality crystalline layers of $(\text{Al}_x\text{Ga}_{1-x})_y\text{In}_{1-y}\text{N}$ can be grown by means of epitaxy methods such as metal organic vapor phase epitaxy (MOVPE) or molecular beam epitaxy (MBE). Typical growth conditions are described in the literature, e.g.

- EP-0-579 897 A1

15 - EP-0-551 721 A2

- "GaN, AlN, and InN: A review" by S. Strite et al., Journal of Vacuum Science and Technology, Vol. B 10, pp. 1237-1266, 1992.

From these References, also descriptions of standard device processing steps such as etching processes, doping $(\text{Al}_x\text{Ga}_{1-x})_y\text{In}_{1-y}\text{N}$ p- and n-type during and after crystal growth with a variety of dopants (e. g. Zn, Cd, Si, and Mg), and the formation of metal coatings resulting in either Schottky barriers or ohmic contacts can be taken. Such fabrication steps are considered as known and are not discussed in detail when they are mentioned in the following in the context of the embodiments of this invention.

The layered structure shown in Fig. 1A comprises a conductive n - $(\text{Al}_x\text{Ga}_{1-x})_y\text{In}_{1-y}\text{N}$ layer 11 on top of the substrate 10, and a further $(\text{Al}_x\text{Ga}_{1-x})_y\text{In}_{1-y}\text{N}$ layer 12 serving as active layer of the LEDs to be realized in this structure. The first-grown n - $(\text{Al}_x\text{Ga}_{1-x})_y\text{In}_{1-y}\text{N}$ layer 11 is either undoped and its n-type conductivity relies on nitrogen vacancies (i.e. unintentionally n-doped), or its conductivity is further increased by n-doping.

1 e.g. by adding donors such as Si or nitrogen vacancies during its growth.
For fabrication of a MIS-type LED based on the layered structure in Fig. 1A,
the top layer 12 must be made insulating by compensating intrinsic donors.
In accordance with this invention, different doping procedures are suitable,
5 depending on the particular application. This doping can be performed
either during or after growth of the active layer. For the compensation, the
same impurities which lead to the multicolor capability of the active layer
can be used.

10 If the multicolor capability of the inventive devices is achieved by exciting at
least two different impurity-induced optical transitions together and thus
mixing different elementary colors, the compensation of the active layer can
be performed during the growth of the active layer, or after its growth by
exploiting methods such as diffusion or ion implantation, thus resulting in a
15 nearly homogeneous distribution of dopants in the active layer 12. In this
case, either at least two different impurities such as Zn in combination with
Cd or high concentrations of one dopant such as Zn, leading to at least two
different impurity states (see introductory part) can be used.

20 However, if the multicolor capability of the inventive LED arrays relies on
lateral variation of the doping conditions in the active layer, it is favorable to
perform the doping after the growth of the active layer. This is favorable if
the doping conditions must be varied spatially over a large range as it is
required if the novel LED array is designed for covering a large range of the
25 visible spectrum. The large lateral variation of the doping conditions
required in this case cannot be easily controlled during growth of the active
layer in the present state of the art. An approach to realize a large lateral
variation of the doping conditions, in accordance with this invention, after
growth of the active layer will be discussed later in context with Fig. 2.

30

In Fig. 1A, the first semiconductor layer 11 grown on the substrate 10 is
characterized as being n-type. However, as has been mentioned in the
introductory portion, the MIS-LEDs to be discussed in the following function

1 also with the first semiconductor layer being p-doped, provided the sign of
the operating bias is reversed. The main difference between both structures
is the larger resistance of a p-layer, resulting in a slightly reduced power
efficiency of the p-layer based MIS-LED.

5 For the thickness of the insulating layer 12 in Fig. 1A, trade-offs exist
leading to optimized values. According to remarks in the introductory
portion, a thickness of the active layer in the range of 20nm - 1 μ m is
reasonable.

10 Fig. 1B depicts a second layered structure which is the main building block
for a second embodiment of this invention, namely a multicolor array of
p-n-type LEDs. The layer sequence 15 - 18 chosen is in some respects
similar to a known structure cited in "Candela-class high-brightness
15 InGaN/AlGaIn double-heterostructure blue-light-emitting diodes" by S.
Nakamura et al., Applied Physics Letters, Vol. 64, No. 13, pp. 1687-1689,
1994. This reference has already been acknowledged in detail in the
introductory portion. We adopt in the following the idea of using a
double-hetero structure consisting of an active layer 17 (Al_xGa_{1-x})_yIn_{1-y}N
20 sandwiched by two (Al_uGa_{1-u})_vIn_{1-v}N cladding layers 16 and 18, one being
p-doped, the other being n-doped. The mole fractions x, y, u, and v are
chosen such that a heterobarrier occurs at the interfaces between active and
cladding layers (e.g. with x=0, y=0.5, v=1, u=0.5). For n- and p-doping of
the cladding layers, Si and Mg, respectively, can be used as dopants. In the
25 above-mentioned article, a single blue-light emitting LED is disclosed which
benefits in terms of brightness and wavelength redshift from impurity
related transitions in the active layer, whereby the impurity Zn has been
introduced during growth, leading to a homogeneous doping of the active
layer. However, in the framework of this invention, the doping has a
30 different role, namely it has to introduce multicolor capability. Again, both
doping approaches having been discussed in the context of Fig. 1A can
be applied, either a doping leading to at least two different impurity
states, this kind of doping being performed either during or after growth of

1 th activ layer 17, or a d ping with a larg lateral variation of the doping
conditions, this doping procedure being performed after growth of the active
layer 17.

5 In the next step, it is shown how structures like those depicted in Fig. 1 can
be doped with a large lateral variation of the doping conditions. This
doping is not only used in the following for adding multicolor capabilities
but also for a modification of the conductivity of semiconductor layers in the
lateral direction. This latter application is relevant for the electrical isolation
10 of adjacent devices in arrays. The task of doping of semiconductor layers
after their growth including the control of a lateral variation of the doping
conditions is divided into a mask step with a subsequent doping step,
whereby several steps of this kind may be sequentially carried through.
During a mask step, the surface of the semiconductor structure to be
15 modified by doping is covered by a mask such that only certain islands on
top of the surface are accessible for dopants. During the subsequent doping
step, the masked semiconductor structure is exposed to dopants. For
doping, all methods are adequate which allow for the controlled
incorporation of dopants into a defined volume of a semiconductor structure
20 through the surface of this structure. Examples of such doping methods are
ion implantation or vapor deposition. An additional annealing leads to a
redistribution of dopants by diffusion within the sample and/or to annealing
of defects. The annealing is optional for ion-implantation since in this case,
its function is mainly to activate dopants rather than to redistribute them.

25 However, after vapor deposition, annealing is mandatory for the
incorporation of dopants into a semiconductor structure. The so-called
'doping conditions' can be described by a set of parameters which
characterize the doping process as completely as possible. The most
important ones are the kind of incorporated dopants and their local
30 concentration described by a 3-dimensional doping profile. In general, if n
different doping conditions must be realized at different locations of a
semiconductor layer, n different mask steps with a subsequent doping step
must be carried through.

1 For GaN-based LEDs, a SiO_2 mask can be used, the mask being fabricated
by growing a SiO_2 layer on top of the semiconductor structure, and
subsequent etching of predefined holes through the SiO_2 overlayer, thus
5 defining areas accessible to the dopants. Through these holes, the active
layer can be doped. This kind of mask fabrication is conventional for
GaN-based devices. Processing steps related to it can be taken from the
above-mentioned Reference EP-0-579 897 -A1.

10 Examples for doping conditions which can be achieved with the
above-mentioned doping procedures and allow for a compensation of n-type
GaN and lead to electroluminescence of GaN in different sections of the
entire visible spectrum are known from the article

15 - "Photoluminescence of Ion-implanted GaN" by J. I. Pankove, Journal of
Applied Physics, Vol. 47, No. 12, pp. 5387-5390, 1976,

and the other References mentioned above in the context of GaN-based
MIS-LEDs. Equivalent data for other members of the family
20 $(\text{Al}_x\text{Ga}_{1-x})_y\text{In}_{1-y}\text{N}$ can be considered as being a continuous function of x and
y.

25 In the following, the fabrication of LEDs on the basis of the structures
depicted in Figs. 1A and 1B are discussed. No special attention is paid for
arrays of variable hue LEDs. Their structures are basically the same as
those of LED arrays with a lateral variation of the doping conditions. In
addition, both types of LED arrays can be fabricated by exploiting the same
processing steps after growth of the active layer. Only the choice of the
doping conditions of the active layer is different for both types of LED
30 arrays. Therefore, also a single monolithic LED array comprising both types
of LEDs can be made by forming a proper pattern of dopants in a single
layered semiconductor structure. For the sake of convenience, only LED

1 arrays with a lateral variation of the doping conditions are treated in the following.

5 In the next step, it is shown in detail how the above-mentioned mask steps and doping procedures are used for the fabrication of multicolor LEDs. In order to give a few examples, the structures shown in Fig. 1 are used as starting points.

10 Fig. 2 shows as an example a 2-dimensional distribution of pixels 1 - 3, each representing one of three elementary colors blue, green, and red. In the following examples, fabrication steps for different LED arrays which reproduce such a pixel distribution are illustrated. It is obvious, that this example can be modified in many ways. The colors, the number of different colors, the size, the shape and the arrangements of the pixels are arbitrary.
15 However, this is an extreme example illustrating relevant features of this invention. This particular arrangement of pixels is suited for full color displays for the presentation of color images, since the arrangement can be interpreted as regular pattern generated from three subpixels, a blue, a green, and a red one, by equal translations in two dimensions.

20 In the following, cross sections through LED arrays along one line of LEDs are shown, and the main fabrication steps of these particular arrays are described. Cross sections in other directions would be qualitatively equivalent as far as the portions of single LEDs are concerned. Differences
25 can appear in the context of electrical isolation between different single devices, for example the isolation of LEDs in x-y line-addressable LED arrays. In the latter case, the x-y addressing can lead to isolation approaches which are different for the x- and y-directions. Such differences are discussed later when 2-dimensional arrays with a high pixel density are
30 treated.

- 1 A first embodiment of this invention is shown in Fig. 3A. It is a multicolor
LED array based on MIS-LEDs which are made from the layered
semiconductor structure in Fig. 1A. It is assumed that
- 5 - the substrate 30 (being equivalent to layer 10 in Fig. 1A) is not conductive,
e.g. sapphire;
 - the LEDs represent light sources whose shape observed in the direction
perpendicular to the substrate 30 corresponds to the pixel distribution in
Fig. 2;
 - 10 - each LED can be biased via one individual metal contact 33.x ($x=1, 2, \dots$)
on top of the active layer 34 (being equivalent to layer 12 in Fig. 1A), this
contact not being shared with other LEDs, and other contacts 32.x ($x=1, 2, \dots$)
which can be shared with other LEDs;
 - the electrical current through the active layer 34 of the LEDs is mainly
15 perpendicular to the substrate 30 since the active layer is thin and its
resistivity is high in comparison to the adjacent layers.

This specification requires the following steps in order to arrive at the
device structure shown in Fig. 3A when starting with the layered
20 semiconductor structure in Fig. 1A. Layer 12 is intended to become the
active layer 34 of the LEDs shown in Fig 3A. Therefore, it must be
compensated with impurities as described above in accordance with the
specified colors of the light sources to be fabricated. Since individual pixels
with three different colors are desired, three different mask steps with
25 subsequent doping steps are required, each step defining the doping
conditions for the active areas of the entire set of equivalent LEDs. The
hatched areas in Fig. 3 indicate regions which have been doped in one of
the before-mentioned doping steps. These areas are marked with the
symbols D_i ($i=1, 2, \text{ and } 3$) in order to distinguish between regions with
30 different doping conditions. The shape of a particular island D_i being
characterized by constant doping conditions has not to be identical with the
shape of light sources to be fabricated. As the thickness of the active layer
is normally about $1 \mu\text{m}$ or less, the desired pixel size is normally larger

1 than the thickness of the active layer 34 (but does not have to be). As the
current injection into the active layer is considered to be mainly
perpendicular to the substrate 30, and the shape of the light sources
basically reflects the distribution of electrical current through the active
5 layer 34, it is mainly the shape of the individual metal contact on top of the
active layer which determines the shape of a particular light source.
Therefore, in order to avoid leakage current in the LEDs, the constantly
doped islands D_i should not be smaller than the contacts 33.x. Limitations
with respect to their shape are mainly given by the space requirements for
10 different devices. Since the shape of the metal contact defines the light
pattern emitted by the LEDs, transparent metals (e. g. ITO, i. e. indium tin
oxide) can be used for the metal contacts if it is desired to collect the light
out of the metal-contact side. Most metals absorb visible light. If such
non-transparent metals are used for the metal contacts, the light of the LEDs
15 can only be emitted through the substrate.

After the definition of islands with constant doping conditions, contacts for
applying a bias to each particular LED are realized. The conductive
semiconductor layer 31 of the LEDs serves as a common electrode to all
20 LEDs unless device isolation is desired and appropriate means for electrical
isolation such as etching of isolation trenches are applied. However, in this
particular example, it is assumed that each LED is individually addressable
by means of one individual contact on top of the compensated regions D_i.
Consequently, the conductive layer 31 can be used as common electrode.
25 As the substrate is assumed to be nonconductive, a physical contact to the
conductive layer 31 must be realized. This can be done by etching a contact
hole through the top layer 34 or using side contacts. However, if the LED
array is large, the conductivity of the doped layer might not be sufficient for
such contacts to the conductive layer 31. Then, a multitude of contact holes
30 or trenches can be etched through the active layer and an appropriate
wiring of conductive material 32.x can be installed to provide a low series
resistance for all LEDs. For biasing a particular LED, contact areas are
defined for each LED on top of the active layer 34 (or D_i), and metal contacts

1 33.x of appropriate shape corresponding to the desired shape of the pixel is
are realized, whereby known procedures for the metallurgy (see References
cited above) and the pattern definition such as photolithographical steps or
printing can be used. The application of these processing steps leads to the
5 structure depicted in Fig. 3A.

For addressing each LED independently, different functional elements might
be added. The contacts 32.x and 33.x could be connected to independent
address lines on top of the structure shown in Fig. 3A, thus providing an
10 external electrical connection to each individual LED. This can be helpful
for connecting to the driver electronics required for biasing the LEDs.
However, other methods known from microelectronic packaging can also be
applied, e. g. the contact areas on the LEDs could be brought into electrical
contact with the wiring on a second module through which the external bias
15 to the contact areas can be applied.

The multicolor array shown in Fig. 3A can be simplified if the substrate is
conductive (e. g. SiC, InGaAlN). In this case, the doped semiconductor layer
11 in combination with the substrate 10 serve as a single common electrode
20 and special contact holes for accessing the doped semiconductor layer can
be avoided. This simplification is shown in Fig. 3B. The simplified structure
is equivalent to the structure in Fig. 3A. Layer 36 corresponds to layer 31.
Only the top contacts 32.x to the conductive semiconductor layer are
replaced by a contact to the substrate 35, which is in this particular example
25 realized as bottom contact 37, thus leading to a simplification of the
fabrication. Top contacts 38.x to the compensated regions D_i define
individual MIS-LEDs. Note the elimination of 32.x due to the conductive
substrate 35 allows a greater portion of the surface area to be dedicated to
color pixels, allowing increased pixel density and higher brightness.

30

Fig. 4A and 4B show a third and a fourth embodiment of this invention. They
demonstrate the application of the inventive idea to LEDs with p-n-junctions.
As an example, it is assumed that the same pattern of pixels having been

1 discuss d in the context f the previous embodiments is transferred to the
layered s miconductor structure depicted in Fig. 1B. The major differences
in comparison with the MIS-type devices are:

- 5 • In order to provide the active layer with multicolor capabilities by
doping after growth of the semiconductor layers, it is important to
tallor the vertical profile of subsequently incorporated dopants
correctly, since the thin active layer 17 or 43 is located in the
p-n-junction and thus is not in direct contact to the surface of the
10 layered semiconductor structure. Care must be taken that a sufficient
number of dopants passes through the top layer 44 of the structure and
reach the active layer 43. Therefore, the top layer - in the example of
Fig. 1B a p-layer - is made as thin as possible, e. g. 100nm - 1 μ m.
Furthermore, it must be taken into account that the proposed doping
15 procedure changes the doping of the layer 44 on top of the active layer
43 and, if the penetration depth of dopants is too high, the doping of
layer 42 underneath as well. Therefore, in order to avoid a shift of the
p-n-junction due to the proposed doping procedure, care must taken
that no part of any cladding layer 42 and 44 is completely compensated
20 during the incorporation of dopants (generally acceptors) into the
active layer 43. This is done by a careful control of the vertical doping
profile and by setting the initial doping concentration of that layer,
which is partly compensated due to the proposed doping procedure,
sufficiently high. An appropriate doping procedure is ion implantation
25 since the distribution of implanted ions is basically a peaked function
whose characteristics, namely its width and the position of its center
with respect to the surface bombarded with ions depend on the ion
energy, on further parameters determined by the nature of the ions
and the implanted material, and on the conditions of further optional
30 processing steps such as annealing. Therefore, choosing appropriate
parameters of the ion implantation process, a concentration of the
dopants in the active layer 43 can be achieved, in accordance with the
requirements of the fabrication of the devices shown in Fig. 4. An

1 alternative approach leading to equivalent results is growth
interruption of the layered semiconductor structure after growth of the
active layer 43, subsequent definition of individual pixels by the
application of the above-mentioned doping procedures, and the
5 continuation of the growth of top cladding layer 44.

- The top layer 44 of the structure shown in Fig. 4B is conductive.
Therefore, the LEDs must be electrically isolated from each other. This
can be done exploiting standard approaches, e. g. by etching isolation
10 trenches through the uppermost cladding layer 44 and the active layer
43 or by making appropriate portions of the uppermost cladding layer
44 insulating, for example by compensation. The latter can be
achieved by exploiting one or more mask steps with subsequent
doping steps. Again, care must be taken for the control of the vertical
15 doping profile in order to avoid leakage currents and electrical
coupling of adjacent LEDs. These effects are present if the
compensation of the top cladding layer 44 in regions between different
LEDs is not complete.
- For p-n-type LEDs, the shape of the top contact is less important for the
shape of the light spot related to a particular LED since a current
spreading occurs in the cladding layers due to their conductivity. The
shape of the multicolor light sources can be defined in two ways, either
by tailoring the lateral current profile within a particular LED (e. g. by
25 electrical isolation, see above) and/or by shaping the lateral profile of
those dopants which are responsible for the radiative transitions in the
active layer.

30 Taking the remarks related to p-n-type LEDs into account, the
above-mentioned steps are applied to the layered structure shown in
Fig. 1B and two novel multicolor p-n-type LED arrays are realized. These
examples are shown in Fig. 4A and 4B. Both examples are equivalent
analogs of the MIS-type LEDs in Fig. 3. In particular, in the case of Fig. 4A,

1 the substrate 41 is insulating. In the case of Fig. 4B, the substrate 47 is
conductive. Again, like in the previous examples, areas with constant
doping conditions are hatched and the symbols D_i ($i = 1, 2, \dots$) are used to
5 distinguish between different doping conditions and thus different colors of
the related light sources. As electrical isolation between adjacent LEDs, the
option of etching away parts of the uppermost cladding layer and the active
layer has been chosen. As to approaches to form contacts for biasing
individual LEDs, the same arguments hold as those given above in the
context of MIS-devices. In particular, if each LED can be biased via an
10 individual contact on top the uppermost cladding layer, the lower cladding
layer 42 can be used as common electrode for all LEDs. Furthermore, if the
substrate is conductive, it is sufficient even for a large substrate to use one
common contact 48 to the substrate and one individual top contact 45.x for
each LED for biasing, whereas in the case of an insulating substrate, a
15 variety of contacts 46.x to the lower cladding layer might be required for
large substrates in order to minimize the series resistance for all LEDs.

In the following, special considerations are made which are related to
2-dimensional arrays with a high density of (MIS- or p-n-type) LEDs. LEDs
20 with radiative areas (in a plane parallel to the substrate) as small as
 $0.1\mu\text{m} \times 0.1\mu\text{m}$ are feasible based on modern semiconductor processing
techniques, thus potentially allowing for a realization of multicolor displays
with a resolution in excess of 100,000,000 pixels per cm^2 . In this context, the
question of how to address an individual pixel must be focussed on. If the
25 pixel density is as high as 100,000,000 pixels per cm^2 , it is not possible to
connect each LED with one individual address line for biasing or even to
two individual address lines if no contact common to all LEDs is available.

The classical solution for such addressing problems is the above-mentioned
30 x-y line addressing, i. e. assuming that each device to be addressed is a
two-terminal device which is activated by applying an appropriate bias
between two terminals and all devices are arranged in a 2-dimensional
regular array such that a particular device can be identified by a particular

1 r w (the x-row) and a particular column (th y-column) of the array. The
addressing of a dense 2-dimensional array of equivalent devices is achieved
by providing 2 orthogonal sets of independent address lines, namely
x-row-lines and y-column-lines, each row-line being attributed to a particular
5 row of the array and each column-line being attributed to a particular
column of the array. In x-y line addressing, one terminal of each particular
device, said terminal being functionally equivalent for all devices, is
connected to the row-line attributed to the device, and the other terminal of
each particular device is connected to the column line attributed to the
10 device, and a particular device is activated by applying a bias to the
appropriate row- and column line, simultaneously.

So far, embodiments of this invention have been discussed which are
characterized by terminals shared between a multitude of devices, either by
15 contacting a conductive semiconductor layer or substrate common to all or
multiple devices or by using a conductive substrate which is connected to
all devices. Such designs allow for the fabrication of LED arrays with a high
spatial LED density since space is saved by sharing terminals. However,
these designs require the biasing of each LED via an individual address
20 line. Therefore, 2-dimensional arrays based on such designs are not suited
for x-y line-addressing, unless a control device is added to each LED, said
device controlling the bias to one independent terminal of a particular LED
and being controlled via x-y line-addressing.

25 In the following, one example of a control device which allows for applying
x-y line-addressing to the novel structures having been discussed so far is
given. An appropriate control device can be a 3-terminal device such as a
transistor, two terminals being connected to a x-row-line and a
y-column-line, both terminals in combination controlling the electrical
30 current flowing through the third terminal. This third terminal of this
controllable current source can be used for biasing one LED whose second
terminal is on a predefined electrical potential. Thus, an x-y addressable
2-dimensional LED array can be realized as a combination of a

1 2-dimensional array of LEDs having one terminal in common, an array of x-y
address lines, and an array of transistors, each transistor being situated at
a node of the x-y address lines and being connected to the address lines
and the LEDs as described above. This approach is suited for monolithic
5 integration, since technologies which have been developed for LCD
displays, in particular the thin-film transistor technology, (see introductory
portion) can be adopted. For thin-film transistors, semiconductor materials
such as amorphous silicon (a-Si), polycrystalline silicon (poly-Si), CdS ,
CdS, amorphous Ge, etc. have been exploited. a-Si and poly-Si are most
10 widely used. An advantage of thin-film transistor technology is the
possibility of providing uniform, reproducible film quality over large areas
by using fabrication methods such as chemical vapor deposition (CVD) or
plasma-enhanced vapor deposition (PECVD), thus the possibility of scaling
transistor circuitry to large sizes, and the compatibility with many classes of
15 materials, which can serve as substrates, e. g. crystalline semiconductors,
metals, dielectrics, glasses, polymers etc.. In accordance with these
characteristics, the known thin-film transistor technology can be combined
with the novel LED arrays under consideration.

20 One example of such a combination is shown in Fig. 5. Fig. 5 shows a
portion of a x-y addressable LED array which is basically the array shown in
Fig. 3B, each LED being connected to one transistor 54 of a transistor array
on top of the LED array, and each transistor being connected to a x-row-line
60 and a y-column line 61 of a network of x-y address lines via two
25 terminals 57 and 58. In Fig. 5, a particular LED is shown, the LED
consisting of a metal contact 55 on top of a stack of three layers 50, 51, and
52, corresponding to the layers 35, 36 and one of the compensated zones D,
in Fig. 3, respectively. The LED is connected via interconnect element 56 to
the third terminal of transistor 54, this terminal providing an appropriate
30 bias to the LED, under control of the bias to the other two terminals 57 and
58 of the transistor. For the isolation of all independent electrically active
parts of the array, the terminals 56-58 of the transistors and the top contacts
55 of the LEDs are imbedded in an insulating layer 53, e. g. in a polyimide

1 layer. Furthermore, the x-y address lines 60,61 are isolated against each other. Equivalently, the other embodiments of this invention can be prepared for x-y addressing.

5 In the above-mentioned example, the thin-film transistors have been introduced as a nonlinear circuit which transforms two input signals, namely signals on an x- and a y-address line, into one signal which is used for biasing a LED which has only one independent terminal and one terminal in common with other LEDs. Thus, the function of the transistor matrix in this
10 case is different from the role of the thin-film transistor circuitry in the case of active-matrix LCD displays, where the transistor is not necessary for activating a particular pixel - this would work without transistors - but helps improving certain limitations which are due to intrinsic physical properties of liquid crystals and their response to electrical fields and lead to image
15 deteriorations such as reduced contrast, reduced viewing angle, cross talk between adjacent pixels etc. (see introductory portion of this description). However, such deteriorations do not appear in 2-dimensional LED arrays consisting of LEDs whose two terminals are directly connected to x-y address lines. The lack of such deteriorations in LED displays is due to
20 several features of LEDs, namely their fast response speed and the fact that the intensity of a particular LED is a strongly nonlinear function of the bias to the LED. Therefore, LED arrays are desired which can operate without a transistor matrix as the connecting element between LEDs and x-y address lines.

25 In the following, examples of multicolor 2-dimensional x-y addressable LED arrays which are in accordance with this invention and operate without a transistor matrix as the connecting element between LEDs and x-y address lines are given. In all these examples, 2 independent terminals of each LED
30 are accessible from the top side of an appropriate layered semiconductor structure and are connected to an array of x-y address lines on top of the structure. In these examples, both independent terminals are situated on a planar surface and a major part of the current which is injected into the

1 activ region of th LEDs fl ws in the lateral direction parallel to the
substrat .

Fig. 6 shows example of a multicolor 2-dimensional x-y addressable LED
5 array which is based on MIS-type LEDs. The fabrication of this particular
structure starts from a single n-type layer 71, which is either undoped (i. e.
unintendedly undoped) or n-doped. In this layer, MIS-type LEDs are
realized in a lateral arrangement. This is done by generating insulating
10 regions by means of the above-mentioned doping techniques, whereby th
doping conditions are chosen such that the insulating regions, which serve
as active regions of the LEDs, are capable of generating radiation with
predefined colors. Regions with different doping conditions are denoted in
Fig. 6 with different symbols D_i ($i=1, 2, \dots$). Contacts 72, 73, 74, and 75 for
15 applying a bias between an insulating region and its n-doped environment
complete a particular LED, whereby - in contrast to the previous
embodiments - the electrons are injected primarily laterally into the active
region where they radiatively recombine with impurity-related holes. For a
suppression of leakage currents between different LEDs and thus cross-talk
20 between different LEDs, electrical isolation 76 between adjacent LEDs can
be introduced. Known isolation approaches are sufficient for the inventive
LED arrays, e. g. etching of deep isolation trenches or doping for
introducing current blocking regions such as p-n-junctions or compensated
(i. e. insulating) regions. The latter approach is obviously an application of
25 the above-mentioned doping techniques. As a major part of the electrical
current flows close to the upper surface of the semiconductor layer 71, the
depth of said isolating regions is an important optimization parameter for
minimizing leakage currents. Perfect isolation can be achieved by using
insulating substrates 70 and perfectly suppressing the lateral current
30 between different LEDs by making the depth of said isolating regions equal
to the thickness of the semiconductor layer 71. Means for isolation 77, 78,
e. g. thin dielectric layers, assure that the address lines 72-75 are
connected only to appropriate terminals of the LEDs and that individual
LEDs can be addressed and activated for the generation of light.

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The structure shown in Fig. 6 can be modified in different ways within the
same concept of lateral Injection of carriers into the insulating region of
MIS-LEDs. The basic idea behind these lateral realizations is that they can
5 be made in a single semiconductor layer grown on a substrate. This
semiconductor layer being the starting point for the fabrication of an array
of MIS-LEDs is intended to be either the (n- or p-) doped region or the
insulating region of the MIS-LEDs, whereby the respective counterparts of
the MIS-LEDs are realized by applying the above-mentioned doping
10 techniques to certain regions on the surface of said semiconductor layer
and by providing metal contacts. In addition, as in the previous example,
means for isolation of adjacent LEDs are optional.

15 A further realization of this general concept is given in Fig. 7. In this case, a
semiconductor layer grown on the substrate 80 is made insulating by
compensation, whereby the above-mentioned doping techniques are used to
introduce a pattern of regions D_i ($i=1, 2, \dots$) with different compensating
doping conditions in accordance with a predefined pattern of colors to be
20 generated by the final LED array. In each of these portions characterized by
constant doping conditions, one or more conductive islands 85-88 are
realized by applying the above-mentioned doping techniques. For reducing
leakage currents, it is favorable to assure that the depth of the conductive
islands is less than the depth of the insulating portions. Metal contacts
25 81, 82 to the insulating portions and contacts to the conductive islands
83, 84 finally complete the MIS-LED array. Again, means for isolation 89 of
adjacent LEDs are optional. Means for isolation 90, 91, e. g. thin dielectric
layers, assure that the address lines 81-84 are connected only to
appropriate terminals of the LEDs and that individual LEDs can be
30 addressed and activated for the generation of light.

So far, it has been assumed that the LEDs are realized in crystalline
semiconductor layers. This choice offers the highest power efficiency
possible. However, due to the limited size of today's substrates appropriate

1 for the growth of high-quality epitaxial layers, the maximum size of LED
arrays based on crystalline layers is also limited to less than the size of
state-of-the-art LCD displays, which are fabricated on glass. Therefore,
displays based on crystalline semiconductor LEDs are best suited for
5 projection applications. In order to overcome the size limitation for the
novel devices under consideration, all epitaxial layers can be replaced by
appropriate thin amorphous or poly-crystalline films of the same material.
The availability of techniques for uniformly depositing such thin films on
large (conductive or insulating) substrates such as glass or any substrate
10 which is used for the thin-film transistor arrays for large active-matrix LCD
displays assures that the novel devices under consideration can be scaled
- like a LCD display - to any size when being realized with thin amorphous
or poly-crystalline semiconductor films.

15 On the basis of the multicolor LED arrays in accordance with this invention,
novel emissive multicolor displays can be made by adding further features
which depend on the particular display application and can be engineered
on the basis of common technologies. So far, a variety of novel monolithic
LED arrays with multicolor capability including means for addressing
20 individual LEDs and applying an appropriate bias to them have been
disclosed, whereby the term 'means for addressing' stands for the
availability of one or more contacts on the monolithic array, said contacts
allowing for biasing any predefined LED by means of a power supply. Any of
these novel LED arrays can be taken as a display's visualizing component
25 making predefined data visible to a viewer, whereby each LED represents a
picture element of the display and the geometry and the color capability of
each LED is designed accordingly. In order to make a complete display from
the disclosed LED arrays, further optional functional elements to be added
can be taken from the following list:

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- a mechanical mount for supporting the LED array such that individual
light sources attributed to individual LEDs can be viewed;

- 1 • control electronics for controlling the bias of said LEDs and thus their light intensity, said control electronics further comprising an interface for receiving image data to be displayed;
- 5 • a timing system for handling time-dependent image data, e. g. video signals;
- a gray-scale processor for handling gray levels of individual subpixels;
- 10 • a pulse generator for biasing the LEDs in a pulsed mode; such a pulsed mode is useful for x-y addressing, where individual pixels are subsequently addressed, for gray-scale processing by adopting pulse lengths, pulse heights, and/or repetition rates of applied pulses, and for the optimization of the power efficiency of the LEDs by reducing the
- 15 heat generation and thus increasing the internal efficiency of the LEDs.

LED arrays offer the possibility of realizing displays with a high pixel density (see above), whereby pixel sizes $1\mu\text{m}$ by $1\mu\text{m}$ or even less are feasible. This feature can be taken as an advantage in projection displays. In projection

20 displays, conventional optics is used to generate real or virtual images of a primary display. The high pixel density and the high brightness of LEDs allow for the application of imaging optics with a large magnification factor in excess of 100. Thus cm size LED arrays can be used to generate m size images which can be projected on a flat screen and can be viewed with a

25 sufficient resolution of 10 pixel/mm. The novel devices disclosed in this description make full color versions of LED based projection displays possible. Such displays are compatible with today's crystalline substrates.

In summary, a concept for making monolithic arrays of light emitting diodes

30 at multiple wavelengths and their use in multicolor displays is presented. Such multicolor displays are valuable in combination with many data generating systems, e. g. computers.

CLAIMS

1. An array of light emitting diodes (LEDs) for the generation of light at multiple wavelengths, the LEDs being realized in a layered structure of semiconductor films (11, 12, 16-18, 31, 34, 36, 39, 42-44, 51, 52, 71) grown on one substrate (10, 15, 30, 35, 41, 47, 50, 70, 80), said array comprising contact areas (32.x, 33.x, 37, 38.x, 45.x, 46.x, 48, 55, 59, 72-75, 81-84) for applying a bias to said LEDs, at least two particular LEDs of said LEDs having different electroluminescence spectra obtained in that
- only the first of said particular LEDs has an electroluminescence spectrum being determined by impurity states in the material forming its active region (12, 17, 34, 39, 43, 52), said impurity states leading to optical transitions with energies below the bandgap energy of said active region, or
 - both of said particular LEDs have at least one impurity state in the material forming the respective active region, said impurity states being different for both of said LEDs due to different local doping conditions, and each of said impurity states leads to optical transitions with energies below the bandgap energy of said active region, said optical transitions contributing to said electroluminescence spectra of said particular LEDs, or
 - said electroluminescence spectra of both of said particular LEDs comprise at least two emission lines with different emission wavelengths, both of said emission lines being attributed to optical transitions which are related to impurity states in the material forming the active region of said LEDs and have a photon energy below the bandgap energy of said active region, said two emission lines having the same photon energy but different relative intensities for said particular LEDs.
2. The array of claim 1, whereby the electroluminescence spectrum of at least one of the two particular LEDs comprises only one emission line at one particular wavelength.

- 1
3. The array of claim 1, whereby the electroluminescence spectrum of at
least one LED of the two particular LEDs comprises at least two emission
lines at two different emission wavelengths, whereby a change of the bias
5 applied to said LED causes a change of the relative intensity of the
electroluminescence at said emission wavelengths of said LED.
- 10 4. The array of any of the claims 1-3, whereby different local doping
conditions are obtained by means of different choices of the dopants and/or
their local concentrations and/or the doping processes.
- 15 5. The array any of claims 1-4, whereby the light of the LEDs is partially
radiated into at least one of the half spaces above or below the substrate.
- 20 6. The array of any of the claims 1 to 5, whereby the substrate is transparent
for the generated light and a part of the generated light is radiated through
the substrate.
- 25 7. The array of any of the claims 1 to 6, whereby a particular LED is based
on a metal-insulator-semiconductor (MIS) structure comprising a metal
contact (33.x, 38.x, 55, 72-75, 81-84) which is in direct contact with an
insulating portion of a semiconducting material (12, 34, 39, 52, D_i , $i=1$,
2, ...), said insulating portion being in direct contact with a conducting
portion of a semiconducting material (11, 31, 36, 51, 71, 85-88) whereby the
dopants (D_i , $i=1, 2, \dots$) responsible for the emission wavelength are
contained in said insulating portion.
- 30 8. The array of claim 7, whereby the metal contact (33.x, 38.x, 55), the
insulating portion of a semiconducting material (34, 39, 52, D_i , $i=1, 2, \dots$)
and the conductive portion of a semiconductive material (31, 36, 51) are
vertically arranged with respect to the substrate (30, 35, 50).

- 1 9. The array of claim 7, whereby said array is characterized in that the
insulating portions (D_i , $i=1, 2, \dots$) and the conducting portions (71, 85-88)
of the LEDs are realized in a single semiconductor layer, this layer being
the top layer of the layered structure, whereby the insulating and/or the
5 conducting portion is realized by a lateral variation of the doping conditions
of the uppermost region at the surface of said top layer.
- 10 10. The array of claim 9, whereby the insulating portion (D_i , $i=1, 2, \dots$) of
an LED is embedded in its conducting portion (71), or whereby the
conducting portion (85-88) of an LED is embedded in its insulating portion (D_i , $i=1, 2, \dots$).
- 15 11. The array of any of the claims 1 to 6, whereby a particular LED is a
p-n-junction (42, 44) based device and the dopants (D_i , $i=1, 2, \dots$)
responsible for the emission wavelength are contained in the active region
(43) of said junction.
- 20 12. The array of any of the claims 7 to 11, whereby the layered structure of
semiconductor films is based on the material system $(\text{Ga}_{1-x}\text{Al}_x)_{1-y}\text{In}_y\text{N}$.
13. The array of any of the claims 1 to 12, whereby the contact areas (32.x,
33.x, 45.x, 46.x, 72-75, 81-84) for applying a bias to a particular LED are on
the same side of the substrate (30, 41, 70, 80).
- 25 14. The array of any of the claims 1 to 12, whereby the substrate is
conductive (35, 47, 50) and serves as a common electrode of at least two
LEDs.
- 30 15. The array of any of the preceding claims, whereby n different
wavelengths, $n \geq 2$, are generated, and n times m LEDs are geometrically
arranged in m equivalent pixels ($m \geq 1$), each pixel containing n adjacent
subpixels, each of the n subpixels being identified with one LED for the
generation of one of the n different wavelengths.

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16. The array of claim 15, whereby the material composition of the semiconductor films is chosen such that the fundamental absorption edge is in the blue or ultraviolet spectral range and the local doping conditions in the active regions of the LEDs are chosen such that at least one subpixel serves for the generation of light in the spectral range between ultraviolet and bluegreen, at least one subpixel serves for the generation of light in the spectral range between bluegreen and yellow, and at least one subpixel serves for the generation of light in the spectral range between yellow and infrared.

17. The array of claim 16, whereby each pixel contains 3 subpixels (1, 2, 3) and the pixels are arranged in a two-dimensional array.

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18. A multicolor display comprising an array in accordance with any of the claims 1 to 17, means for addressing individual LEDs and applying a bias to their contact areas, and a mechanical mount for supporting said array such that individual light sources attributed to the LEDs can be viewed.

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19. The multicolor display of claim 18, further comprising control electronics for controlling the bias of said LEDs and thus their light intensity, said control electronics further comprising an interface for receiving image data to be displayed.

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20. The multicolor display of claim 19, said control electronics further comprising a timing system for handling time-dependent image data and/or a gray-scale processor for handling gray levels of individual subpixels and/or a pulse generator for biasing the LEDs in a pulsed mode.

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21. A multicolor projection display, comprising a multicolor display in accordance with any of claims 18 to 20 and an optical imaging system for a projection of the light sources of said multicolor display.

1 22. The multicolor projection display of claim 21 for a projection on a
screen.

23. A computer comprising a multicolor display in accordance with any of
5 the claims 18 to 22.

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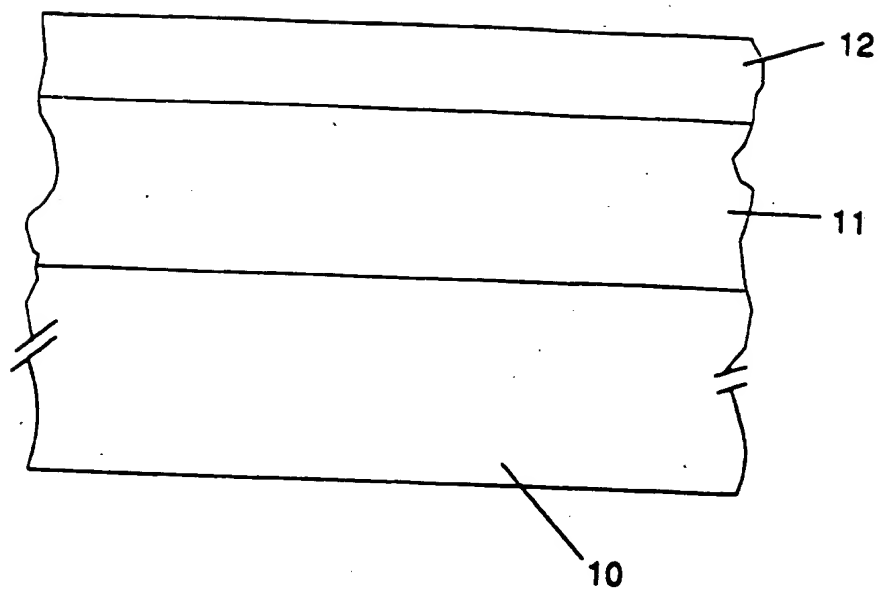


FIG. 1A

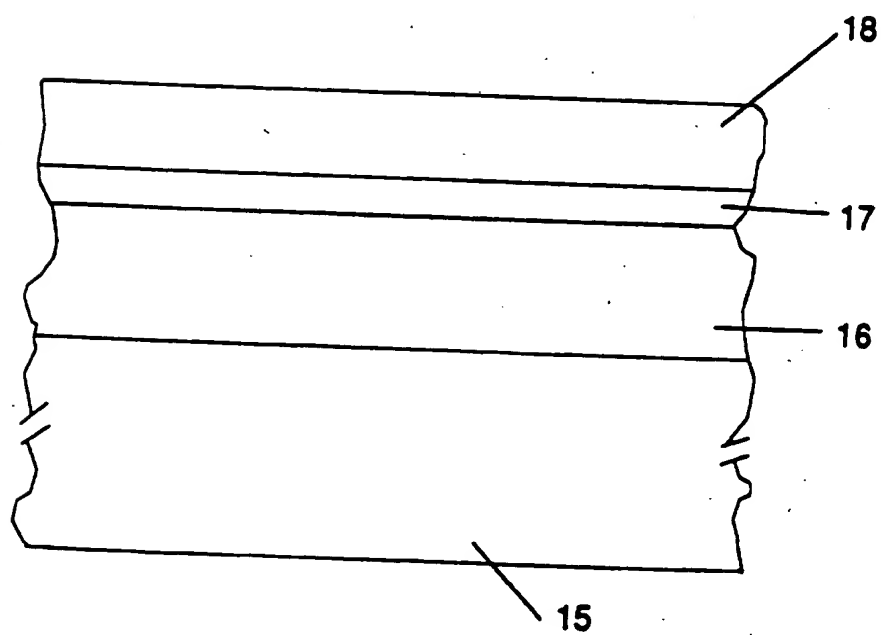


FIG. 1B

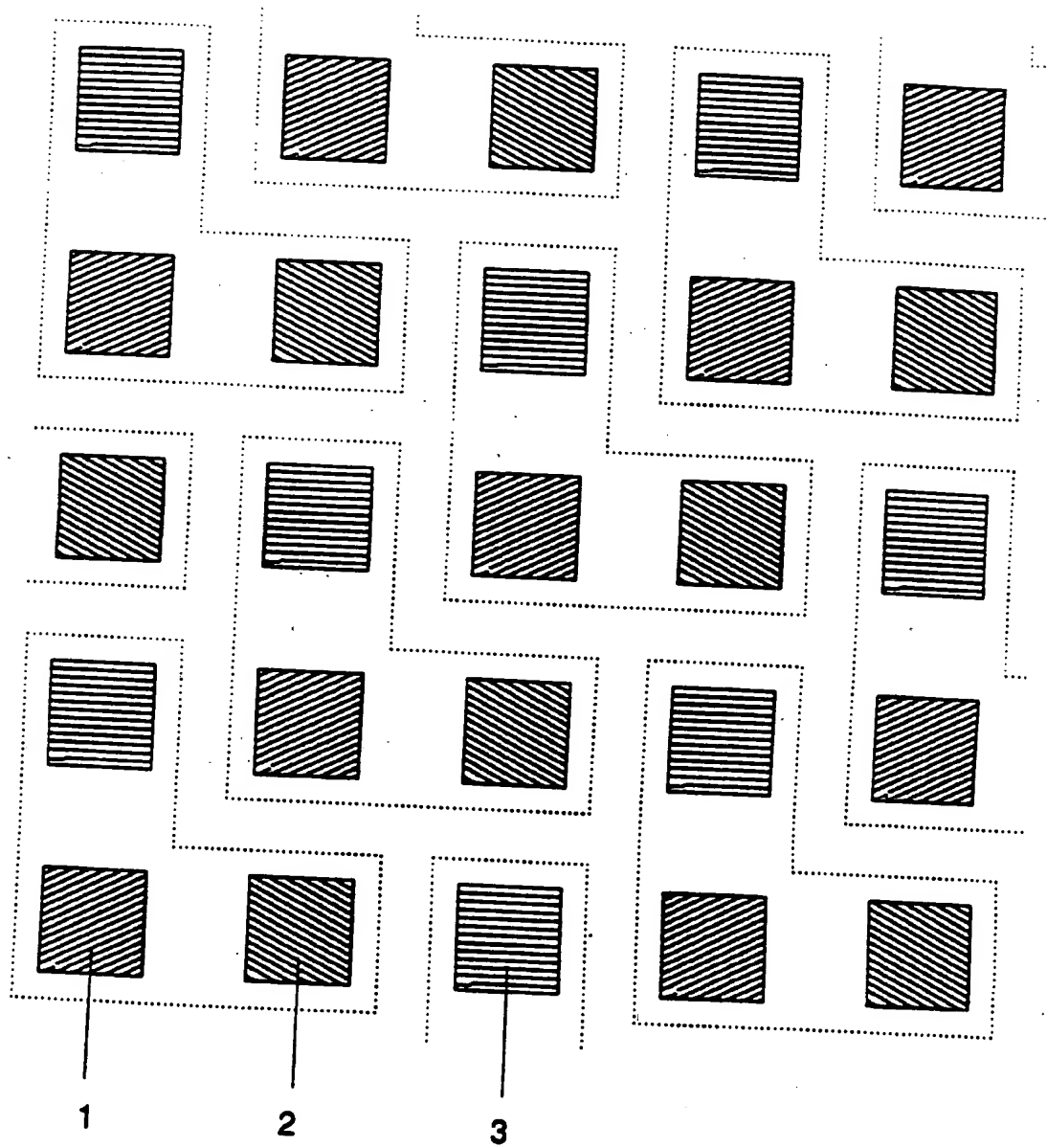


FIG. 2

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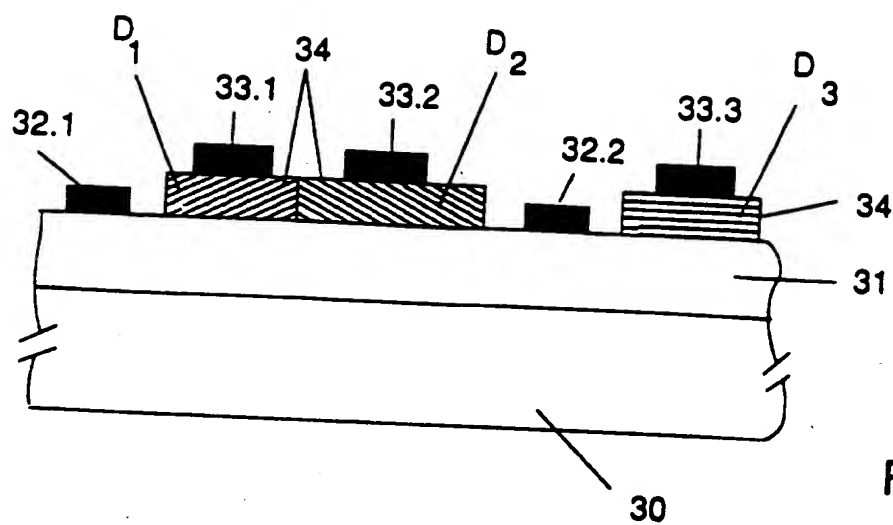


FIG. 3A

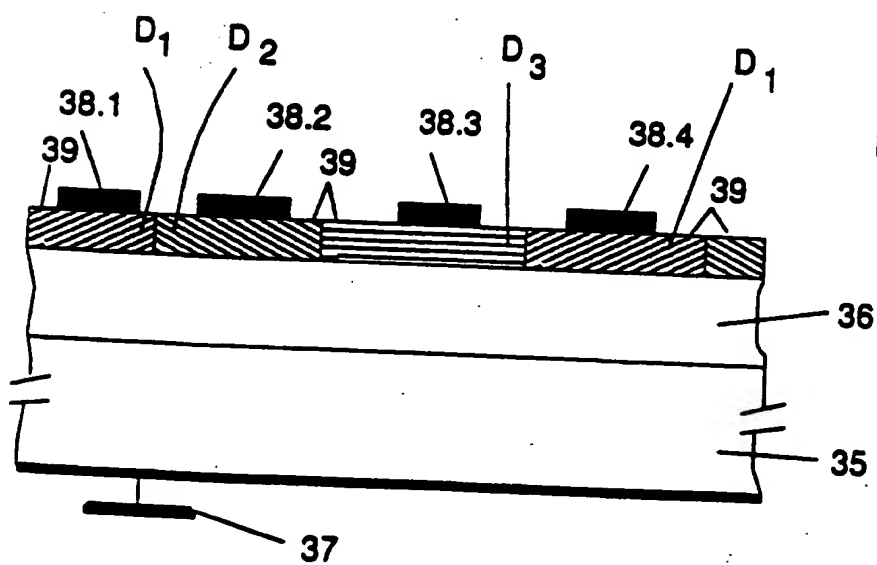


FIG. 3B

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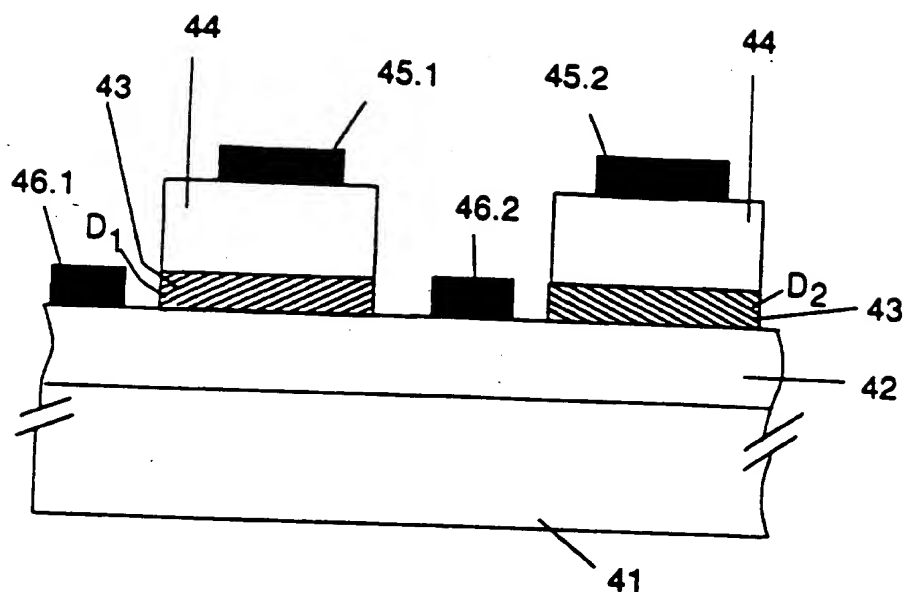


FIG. 4A

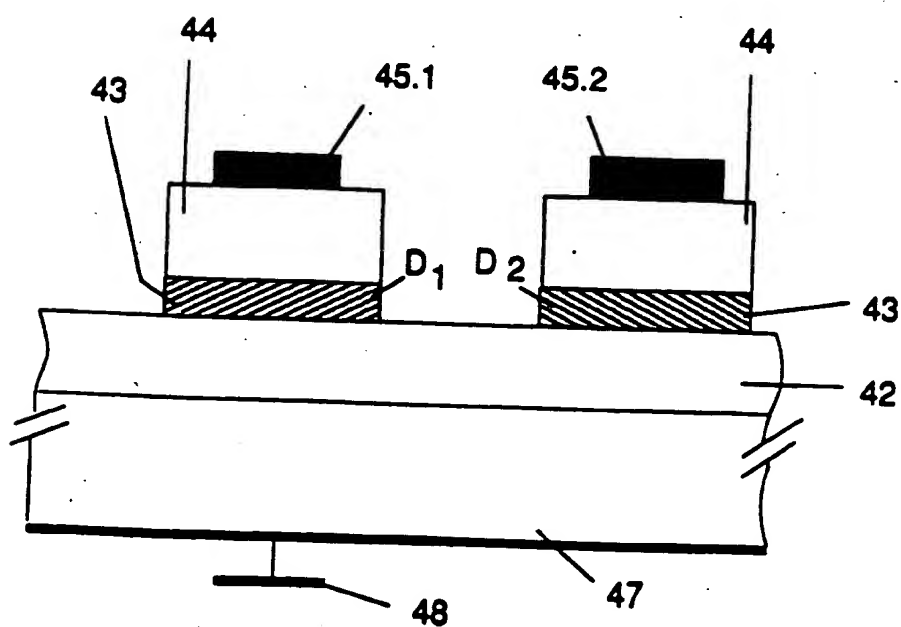


FIG. 4B

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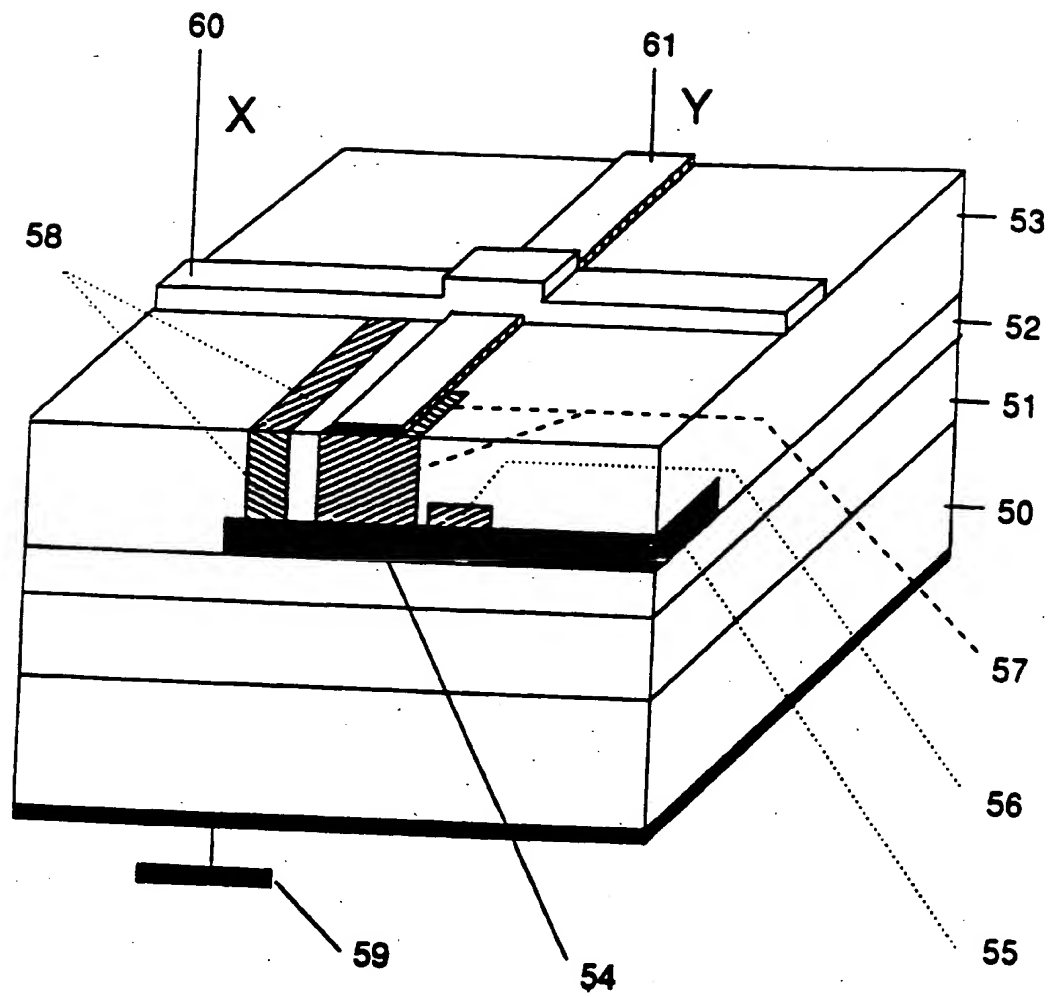


FIG. 5

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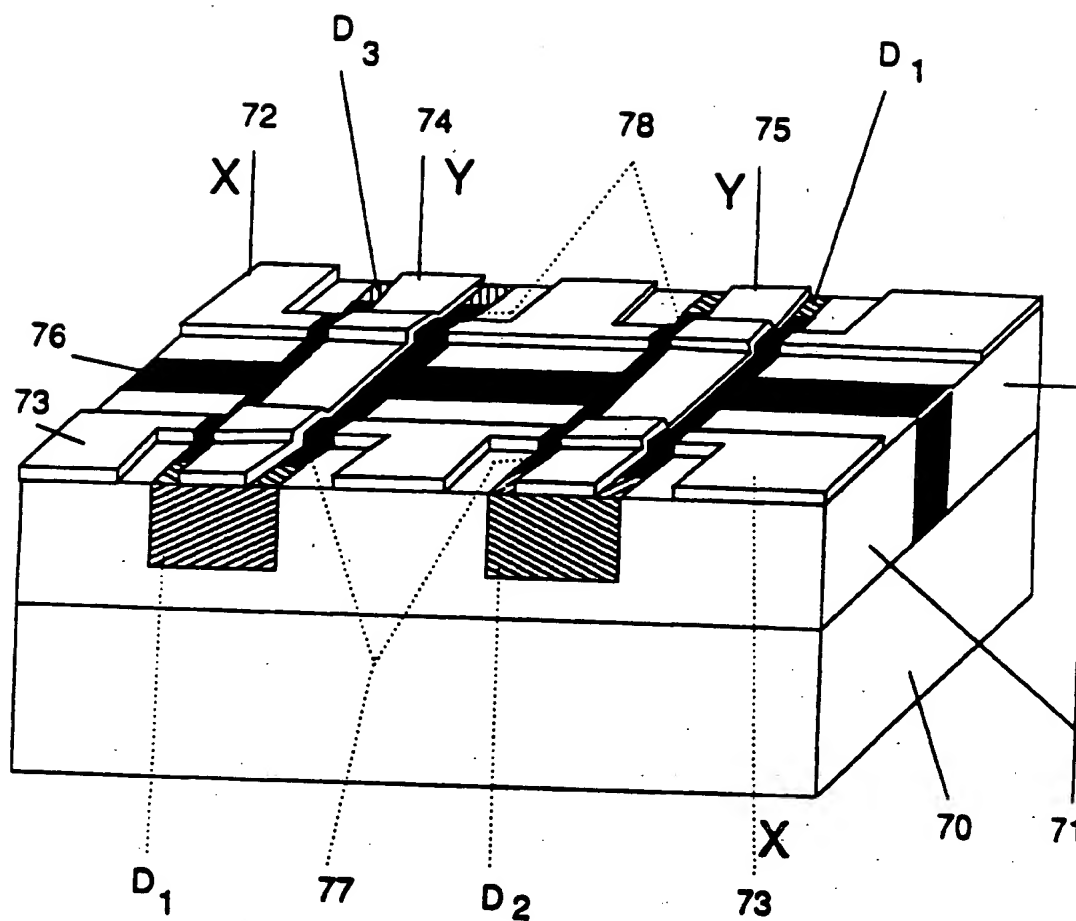


FIG. 6

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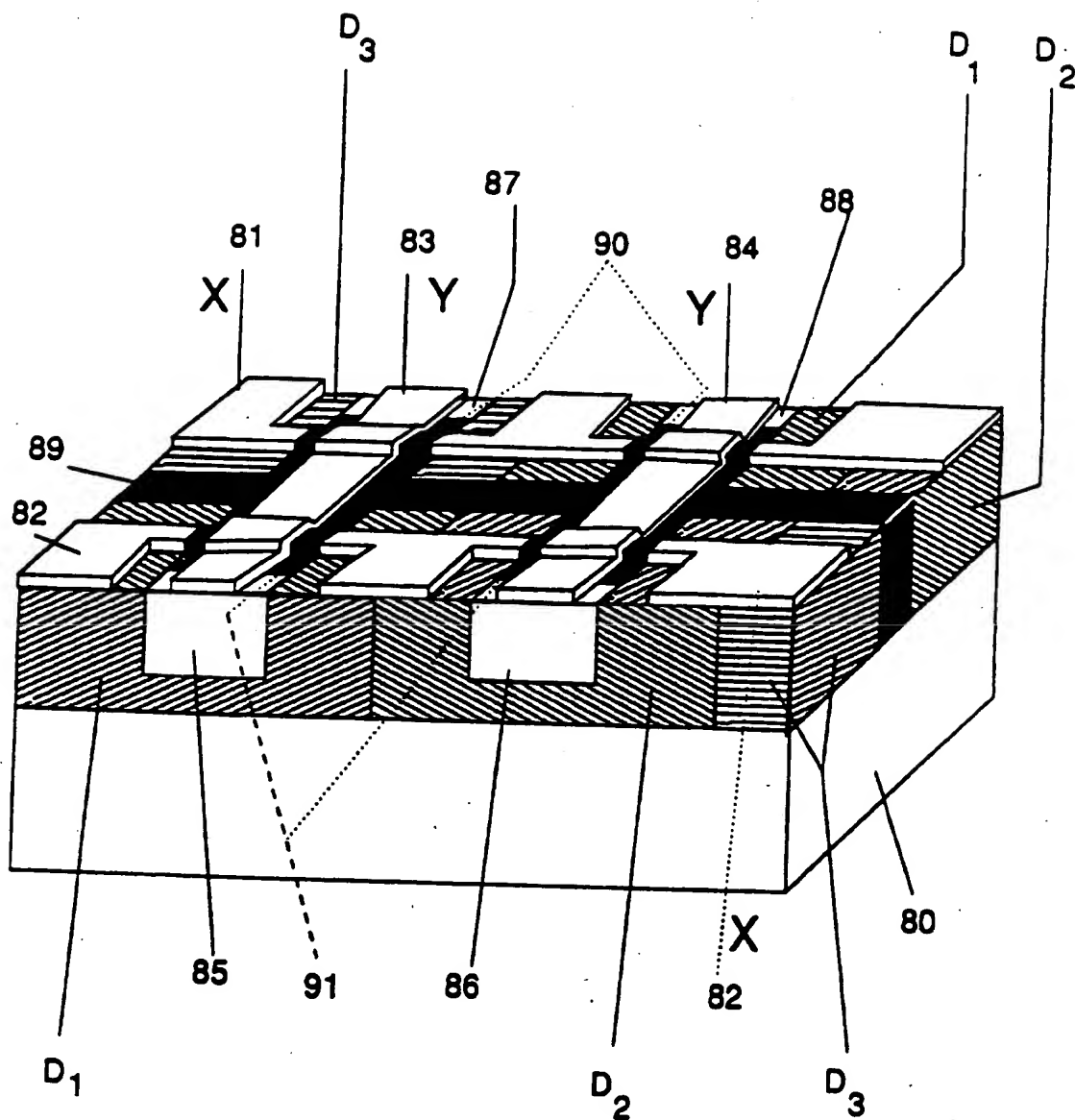


FIG. 7

A. CLASSIFICATION OF SUBJECT MATTER IPC 6 H01L27/15		PC/EPC 94/03346
According to International Patent Classification (IPC) or to both national classification and IPC		
B. FIELDS SEARCHED Minimum documentation searched (classification system followed by classification symbols) IPC 6 H01L		
Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched		
Electronic data base consulted during the international search (name of data base and, where practical, search terms used)		
C. DOCUMENTS CONSIDERED TO BE RELEVANT		
Category *	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
X A X	EP,A,0 351 867 (SHARP KK) 24 January 1990 see column 4, line 35 - column 5, line 25 see column 9, line 36 - column 10, line 16; figures 11,12 --- US,A,4 303 931 (M. GAFFRE) 1 December 1981 see the whole document --- <div style="text-align: center;">-/-</div>	1,2,4-6, 8,13, 15-17 7,11,14, 17 1,2,4-6, 11,13-15
<input checked="" type="checkbox"/> Further documents are listed in the continuation of box C. <input checked="" type="checkbox"/> Patent family members are listed in annex.		
* Special categories of cited documents: <div style="display: flex; justify-content: space-between;"> <div style="width: 48%;"> <p>"A" document defining the general state of the art which is not considered to be of particular relevance</p> <p>"E" earlier document but published on or after the international filing date</p> <p>"L" document which may throw doubts on priority claim(s) or which is cited to establish the publication date of another citation or other special reason (as specified)</p> <p>"O" document referring to an oral disclosure, use, exhibition or other means</p> <p>"P" document published prior to the international filing date but later than the priority date claimed</p> </div> <div style="width: 48%;"> <p>"T" later document published after the international filing date or priority date and not in conflict with the application but cited to understate the principle or theory underlying the invention</p> <p>"X" document of particular relevance; the claimed invention cannot be considered novel or cannot be considered to involve an inventive step when the document is taken alone</p> <p>"Y" document of particular relevance; the claimed invention cannot be considered to involve an inventive step when the document is combined with one or more other such documents, such combination being obvious to a person skilled in the art</p> <p>"Z" document member of the same patent family</p> </div> </div>		
Date of the actual completion of the international search <div style="text-align: center;">24 May 1995</div>	Date of mailing of the international search report <div style="text-align: center;">09.06.95</div>	
Name and mailing address of the ISA European Patent Office, P.B. 2818 Paternoster 2 NL - 2280 HV Rijswijk Tel.: (+31-70) 340-2040, Tlx. 31 631 epo nl, Fax: (+31-70) 340-3016	Authorized officer <div style="text-align: center;">De Laere, A</div>	

INTERNATIONAL SEARCH REPORT

International Application No.
PCT/EP 94/03346

C.(Continuation) DOCUMENTS CONSIDERED TO BE RELEVANT

Category	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
X	MICROELECTRONICS, 1974, UK, vol. 5, no. 3, ISSN 0026-2692, pages 21-29, KENNEDY D I 'Fabrication and properties of gallium phosphide variable colour displays' see the whole document ---	1,3,5, 11,13
A	SOVIET TECHNICAL PHYSICS LETTERS, vol. 12, no. 5, May 1986 NEW YORK US, page 221 DMITRIEV V A ET AL 'Three-color blue-green-red display made from one single crystal' see the whole document ---	1,2,4,5, 11,14-17
A	IBM JOURNAL OF RESEARCH AND DEVELOPMENT, JAN. 1992, USA, vol. 36, no. 1, ISSN 0018-8646, ALT P M ET AL 'A gray-scale addressing technique for thin-film-transistor/liquid crystal displays' cited in the application. see the whole document -----	1,18-23

INTERNATIONAL SEARCH REPORT

Information on patent family members

Internat. Application No.

PCT/EP 94/03346

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